## Application/Control No. 10/643,700 Applicant(s)/Patent Under Reexamination KLEINERMAN, MARCOS Y. Examiner Gail Verbitsky Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,374,328	02-1983	Tekippe et al.	250/458.1
	В	US-4,569,570	02-1986	Brogardh et al.	385/12
	С	US-4,708,494	11-1987	Kleinerman, Marcos	374/161
	D	US-4,729,668	03-1988	Angel et al.	374/161
	E	US-5,302,025	04-1994	Kleinerman, Marcos Y.	374/131
	F	US-5,304,809	04-1994	Wickersheim, Kenneth A.	250/458.1
	G	US-5,991,479	11-1999	Kleinerman, Marcos Y.	385/31
	н	US-5,499,313	03-1996	Kleinerman, Marcos Y.	385/123
	ı	US-5,332,316	07-1994	Kleinerman, Marcos Y.	374/161
	J	US-6,648,506	11-2003	McGrath et al.	374/161
	к	US-2002/0158212	10-2002	French et al.	250/459.1
	L	US-6,664,111	12-2003	Bentsen et al.	436/68
	М	US-6,515,289	02-2003	Kask, Peet	250/459.1

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	α					
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	S					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.